Applicant(s)/Patent Under Application/Control No. Reexamination 10/661,112 LAINE, JOHN Notice of References Cited Examiner Art Unit Page 1 of 1 Stephen Avila 3617 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 114/140 10-1994 Helleberg, Niels C. US-5,351,638 Α 441/79 11-2000 Redmon et al. US-6,149,479 В 114/332 01-1996 Nedderman, Jr. William H. С US-5,487,351 441/79 US-6,053,789 04-2000 Miyashiro, Lawrence D E US-US-F US-G н US-US-1 US-J US-K US-L US-Μ FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.